

<b>Search Notes</b>  <b>*1056611</b>  <b>2*</b>	<b>Application/Control No.</b>  10566112	<b>Applicant(s)/Patent Under Reexamination</b>  CHEN ET AL.
	<b>Examiner</b>  D. L. Jones	<b>Art Unit</b>  1618

SEARCHED			
Class	Subclass	Date	Examiner
424	1.11, 1.65, 1.69, 1.73, 1.81, 1.85, 1.89, 9.1, 9.2	11/22/10	dj
534	7, 10-16	11/22/10	dj

SEARCH NOTES		
Search Notes	Date	Examiner
inventors search; STN; consulted parent applications	11/22/10	dj

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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